

March 2009

# FDG6332C F085

## 20V N & P-Channel PowerTrench® MOSFETs

### **Features**

• Q1 0.7 A, 20V.  $R_{DS(ON)} = 300 \text{ m}\Omega$  @  $V_{GS} = 4.5 \text{ V}$ 

 $R_{DS(ON)}$  = 400 m $\Omega$  @  $V_{GS}$  = 2.5 V

 $\bullet \quad \textbf{Q2} \quad -0.6 \text{ A}, -20 \text{V}. \qquad R_{DS(ON)} = 420 \text{ m}\Omega \text{ @ V}_{GS} = -4.5 \text{ V}$ 

 $R_{DS(ON)}$  = 630 m $\Omega$  @  $V_{GS}$  = -2.5 V

- · Low gate charge
- $\bullet~$  High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- SC70-6 package: small footprint (51% smaller than SSOT-6); low profile (1mm thick)
- Qualified to AEC Q101
- · RoHS Compliant

# **General Description**

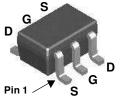
The N & P-Channel MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices have been designed to offer exceptional power dissipation in a very small footprint for applications where the bigger more expensive TSSOP-8 and SSOP-6 packages are impractical.

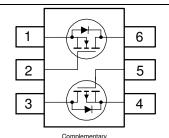
### **Applications**

- DC/DC converter
- Load switch
- LCD display inverter





SC70-6



### **Absolute Maximum Ratings** T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter	Q1	Q2	Units	
V <sub>DSS</sub>	Drain-Source Voltage		20	-20	V
V <sub>GSS</sub>	Gate-Source Voltage		±12	±12	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1)	0.7	-0.6	Α
	- Pulsed		2.1	-2	
$P_D$	Power Dissipation for Single Operation (Note 1)		0	W	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperati	–55 to	°C		

### **Thermal Characteristics**

R <sub>0JA</sub> Thermal Resistance, Junction-to-Ambient	(Note 1)	415	°C/W
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### Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity	
.32	FDG6332C_F085	7"	8mm	3000 units	

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Symbol	Parameter		Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		,		I.		
BV <sub>DSS</sub>	Drain-Source Breakdown Volta	ıge	$V_{GS} = 0 \text{ V}, \qquad I_D = 250 \mu\text{A} \qquad \textbf{Q1}$ $V_{GS} = 0 \text{ V}. \qquad I_D = -250 \mu\text{A} \qquad \textbf{Q2}$	20 –20			V
<u>ΔBV<sub>DSS</sub></u>	Breakdown Voltage Temperatu	re	$V_{GS} = 0 \text{ V}, \qquad I_D = -250 \mu\text{A} \qquad \textbf{Q2}$ $I_D = 250 \mu\text{A}, \text{Ref. to } 25^{\circ}\text{C} \qquad \textbf{Q1}$	-20	14		mV/°C
$\Delta T_J$	Coefficient		$I_D = -250 \mu A, Ref. to 25^{\circ}C$ Q2 $V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$ Q1		-14	1	μΑ
I <sub>DSS</sub>	Zero Gate Voltage Drain Currer	nt	$V_{DS} = 16 \text{ V},  V_{GS} = 0 \text{ V}$ Q2			<u>-</u> 1	μΑ
I <sub>GSSF</sub> /I <sub>GSSR</sub>	Gate-Body Leakage, Forward		$V_{GS} = \pm 12 \text{ V},  V_{DS} = 0 \text{ V}$			±100	nA
I <sub>GSSF</sub> /I <sub>GSSR</sub>	Gate-Body Leakage, Reverse		$V_{GS} = \pm 12V$ , $V_{DS} = 0 V$			±100	nA
On Char	acteristics (Note 2)	1		1	1	1	
$V_{\text{GS(th)}}$	Gate Threshold Voltage	Q1	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.6	1.1	1.5	٧
		Q2	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-0.6	-1.2	-1.5	
$\Delta V_{GS(th)} \over \Delta T_{,I}$	Gate Threshold Voltage Temperature Coefficient	Q1 Q2	$I_D = 250 \mu A, Ref. To 25^{\circ}C$ $I_D = -250 \mu A, Ref. to 25^{\circ}C$		-2.8 3		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source	Q1	$V_{GS} = 4.5 \text{ V}, I_D = 0.7 \text{ A}$		180	300	mΩ
-(- /	On-Resistance		$V_{GS} = 2.5 \text{ V},  I_D = 0.6 \text{ A}$		293	400	
			$V_{GS} = 4.5 \text{ V},  I_D = 0.7 \text{A}, T_J = 125^{\circ} \text{C}$ $V_{GS} = -4.5 \text{ V},  I_D = -0.6 \text{ A}$		247	442	
		Q2	$V_{GS} = -4.5 \text{ V}, I_D = -0.6 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -0.5 \text{ A}$		300 470	420 630	
			V <sub>GS</sub> =-4.5 V, I <sub>D</sub> =-0.6 A,T <sub>J</sub> =125°C		400	700	
<b>g</b> Fs	Forward Transconductance	Q1	$V_{DS} = 5 \text{ V}$ $I_{D} = 0.7 \text{ A}$		2.8		S
		Q2	$V_{DS} = -5 \text{ V}$ $I_{D} = -0.6 \text{A}$		1.8		
$I_{D(on)}$	On-State Drain Current	Q1	$V_{GS} = 4.5 \text{ V},  V_{DS} = 5 \text{ V}$	1			Α
		Q2	$V_{GS} = -4.5 \text{ V}, \ V_{DS} = -5 \text{ V}$	-2			
Dynamic	Characteristics						
C <sub>iss</sub>	Input Capacitance	Q1	V <sub>DS</sub> =10 V, V <sub>GS</sub> = 0 V, f=1.0MHz		113		pF
		Q2	$V_{DS}$ =-10 V, V $_{GS}$ = 0 V, f=1.0MHz		114		
Coss	Output Capacitance	Q1	$V_{DS}$ =10 V, V $_{GS}$ = 0 V, f=1.0MHz		34		pF
		Q2	$V_{DS}$ =-10 V, V $_{GS}$ = 0 V, f=1.0MHz		24		
$C_{\text{rss}}$	Reverse Transfer Capacitance	Q1	V <sub>DS</sub> =10 V, V <sub>GS</sub> = 0 V, f=1.0MHz		16		pF
		Q2	$V_{DS}$ =-10 V, V $_{GS}$ = 0 V, f=1.0MHz		9		
Switchin	g Characteristics (Note 2)						
t <sub>d(on)</sub>	Turn-On Delay Time	Q1	For <b>Q1</b> :		5	10	ns
		Q2	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 1 \text{ A}$		5.5	11	
t <sub>r</sub>	Turn-On Rise Time	Q1	$V_{GS}$ = 4.5 V, $R_{GEN}$ = 6 $\Omega$		7	15	ns
		Q2	For <b>Q2</b> :		14	25	
$t_{d(off)}$	Turn-Off Delay Time	Q1	$V_{DS} = -10 \text{ V},  I_{D} = -1 \text{ A}$ $V_{GS} = -4.5 \text{ V},  R_{GEN} = 6 \Omega$		9	18	ns
+	Turn Off Fall Time	Q2			6 1.5	12	no
$t_f$	Turn-Off Fall Time	Q1 Q2	-		1.5	3.4	ns
Q <sub>g</sub>	Total Gate Charge	Q1	For <b>Q1</b> :		1.1	1.5	nC
y	Table Sale Sharge	Q2	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.7 A		1.4	2	1
Q <sub>gs</sub>	Gate-Source Charge	Q1	$V_{GS}$ = 4.5 V, $R_{GEN}$ = 6 $\Omega$		0.24		nC
		Q2	For <b>Q2</b> : V <sub>DS</sub> =–10 V, I <sub>D</sub> = –0.6 A		0.3		
$Q_{\text{gd}}$	Gate-Drain Charge	Q1	$V_{DS} = -10 \text{ V},  T_{D} = -0.6 \text{ A}$ $V_{GS} = -4.5 \text{ V},  R_{GEN} = 6 \Omega$		0.3		nC
		Q2			0.4		

Electrical Characteristics T <sub>A</sub> = 25°C unless otherwise noted								
Symbol	Parameter		Test Conditions		Min	Тур	Max	Units
Drain-Source Diode Characteristics and Maximum Ratings								
Is	Maximum Continuous Drain-Source Diode Forward Current Q1						0.25	Α
	<b>Q2</b> -0.25							
V <sub>SD</sub>	Drain-Source Diode Forward		$V_{GS} = 0 \text{ V}, I_{S} = 0.25 \text{ A}$	(Note 2)		0.74	1.2	V
	Voltage	Q2	$V_{GS} = 0 \text{ V}, I_{S} = -0.25 \text{ A}$	(Note 2)		-0.77	-1.2	

#### Notes

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

<sup>1.</sup> R<sub>BJA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>BJA</sub> is guaranteed by design while R<sub>BJA</sub> is determined by the user's board design. R<sub>BJA</sub> = 415°C/W when mounted on a minimum pad of FR-4 PCB in a still air environment.

## **Typical Characteristics: N-Channel**

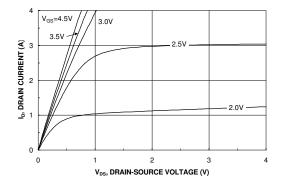


Figure 1. On-Region Characteristics.

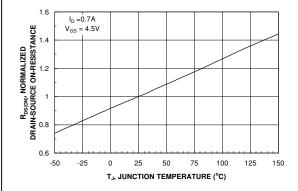


Figure 3. On-Resistance Variation with Temperature.

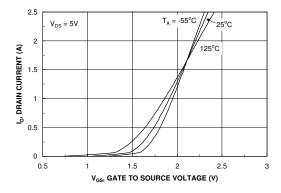


Figure 5. Transfer Characteristics.

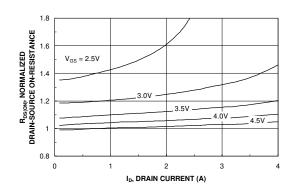


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

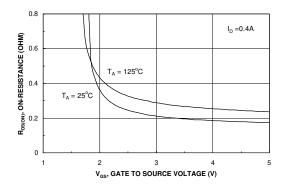


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

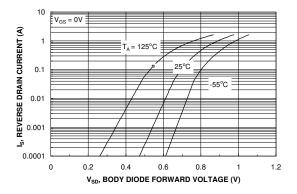


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics: N-Channel**

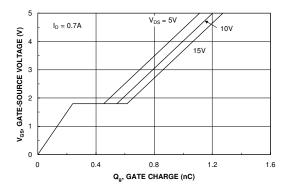


Figure 7. Gate Charge Characteristics.

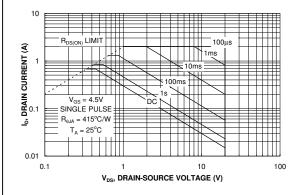


Figure 9. Maximum Safe Operating Area.

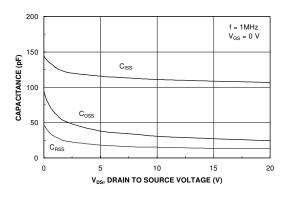


Figure 8. Capacitance Characteristics.

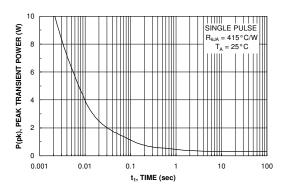


Figure 10. Single Pulse Maximum Power Dissipation.

## **Typical Characteristics: P-Channel**

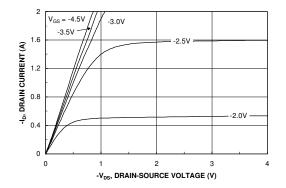


Figure 11. On-Region Characteristics.

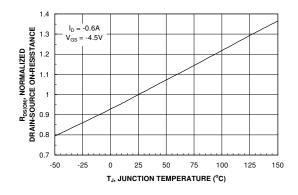


Figure 13. On-Resistance Variation with Temperature.

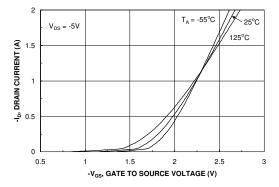


Figure 15. Transfer Characteristics.

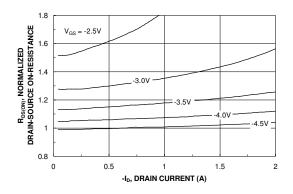


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

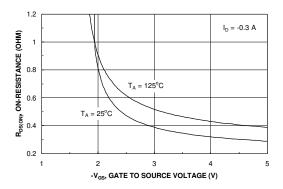


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

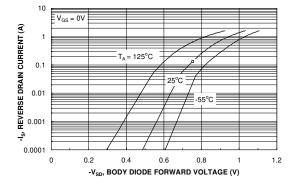
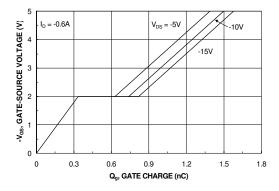


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics: P-Channel**



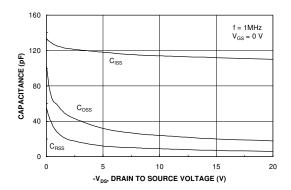
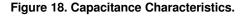
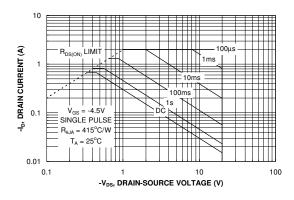


Figure 17. Gate Charge Characteristics.





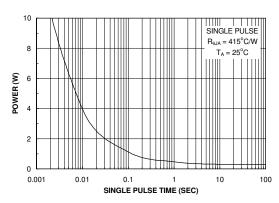


Figure 19. Maximum Safe Operating Area.

Figure 20. Single Pulse Maximum Power Dissipation.

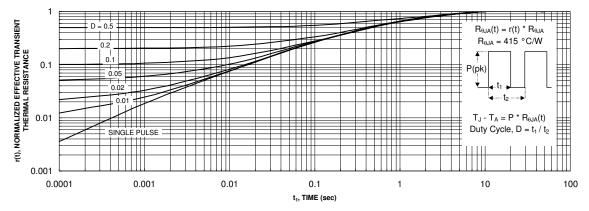


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1. Transient thermal response will change depending on the circuit board design.





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